

VUV-excited Device with Blue-emitting Phosphor

Cross References to Related Applications

This application claims the benefit of U.S. Provisional Application Nos. 60/470,734
5 and 60/470,635, both filed May 15, 2003.

Technical Field

This invention relates to blue-emitting phosphors and mixtures thereof for use in
plasma display devices or other vacuum ultraviolet (VUV) excited devices. These
10 devices include, in part, such apparatus as a plasma display panel or vacuum ultraviolet
excited lamp which consist in part of a sealed transparent structure filled with a rare gas
or a mixture of such rare gases and also containing red-, green-, or blue-emitting
phosphors. A high voltage electrical current produces a gas discharge which emits
vacuum ultraviolet radiation as a primary source of excitation. The VUV radiation then
15 excites the phosphors to emit visible light.

Background of the Invention

Conventional plasma display devices are filled with rare gases (e.g., helium, neon,
argon, xenon, and krypton) or mixtures of rare gases, which are excited by a high
20 voltage electrical current to emit ultraviolet radiation in the VUV range below 200 nm
in wavelength. This emitted VUV radiation is then used a primary source of excitation
to excite various blue, green, and red emitting phosphors. The plasma display panels
(PDP) are made with a back carrier plate, a transparent front plate, and a ribbed
structure, which divides the space between the front and back plates into cells. The
25 plasma display panels also contain a sophisticated electrode array, which can address
and excite each discrete plasma cell individually. Each cell contains a small amount of
the rare gas mixture and a small quantity of phosphor, which emits only one of the
three colors. Cells containing phosphors which emit with each of the three distinct
colors, red, green, and blue, are statistically distributed on the back plate within the
30 panel in much the same fashion as the different colored pixels are distributed in other
types of display panels, such as CRT displays. Like plasma display panels, VUV-

excited lamps also contain rare gases or mixtures of rare gases and si
The excitation-emission principles are similar to display panels exce
blue, green, and red phosphors are broadly coated on the inside of a lamp and emit with
an intent to generate an overall white color instead of the three separate colors which
5 are emitted by the various discrete plasma cells.

The most commonly used VUV excitation energy comes from xenon or xenon-helium
plasmas, which emit in the region 147 nm to 173 nm. The exact emission spectra
depends on the Xe concentration and overall gas composition. Under high voltage
10 excitation, Xe-based plasmas typically have a Xe emission line at 147 nm and a Xe
excimer band emission around 173 nm. This is very different from the primary 254 nm
excitation radiation produced by the low-pressure, mercury vapor discharge of
conventional fluorescent lamps. As a result, phosphors used in VUV-excited
applications have new requirements imposed on them by the higher excitation energies
15 as compared to conventional short-wave ultraviolet fluorescent applications.

In general, the phosphors used in VUV-excited devices exhibit some undesirable
properties. However, the most problematic is the phosphor commonly used as the blue
emitter, europium-activated barium magnesium aluminate (BAM), $\text{Ba}_{1-x}\text{Eu}_x\text{MgAl}_{10}\text{O}_{17}$
20 $(0.01 < x < 0.20)$. This phosphor is known to degrade in both brightness and color
during the manufacturing process due to elevated temperatures and humidity. During
manufacture of PDP panels, a thin MgO layer is applied for the purpose of protecting
the transparent front plate and dielectric layer. MgO is quite hygroscopic and the high
humidity conditions found during manufacture of the panels arise from water that is
25 dissociated from the MgO layer during bakeout. This water is believed to be
instrumental in the degradation in color causing a shift in the color point towards the
green region. This phosphor also degrades in both brightness and color after extended
exposure to the high intensity Xe plasma and VUV photon flux. The degradation
mechanisms of BAM are the subject of much study and are thought to involve such
30 changes as oxidation of Eu^{2+} to Eu^{3+} , modifications in the actual structure of the
aluminate phosphor lattice, and movement of the Eu^{2+} activator ions between different

sites within the lattice. The actual life of a commercial plasma dramatically shortened due to the shift in the color point and reductive the blue phosphor component, which leads to an undesirable yellow shift in the overall panel color. One highly relevant measure of this degradation is the ratio of the intensity (I) to the CIE y color point which can be calculated as a percentage. Both the intensity decrease and the increase in CIE y color coordinate (green shift) result in a reduction of the I/y ratio.

In recent years, a number of different approaches have been attempted in order to improve the maintenance of blue-emitting VUV-excited BAM phosphors. These approaches include sol-gel coating of wide bandgap metal oxides onto BAM phosphor, U.S. Patent Publication No. 2002/0039665; thermal treatments of aluminate phosphors mixed with ammonium fluorides, U.S. Patent No. 6,242,043; and solution based catena-polyphosphate coatings of BAM phosphor, U.S. Patent No. 5,998,047. Substitutional variations of the BAM stoichiometry have also been attempted in order to improve the maintenance of BAM such as substitution of alkali metals, alkaline earth metals, or zinc for one or more of the metallic components in BAM, U.S. Patent Publication No. 2002/0190240 A1. To date, none of these approaches have been entirely successful.

In addition, new phosphor compositions have been investigated which exhibit improved maintenance relative to commercial BAM phosphors such as $(\text{La}_{1-x-y-z}\text{Tm}_x\text{Li}_y\text{Sr}_z)\text{PO}_4$, U.S. Patent No. 5,989,454; $\text{Ba}_{1-a}\text{Eu}_a\text{MgAl}_6\text{O}_{11}$, U.S. Patent No. 6,527,978; $\text{CaMgSi}_2\text{O}_6:\text{Eu}^{2+}$; and $\text{CaAl}_2\text{O}_4:\text{Eu}^{2+}$. A solid solution phase of BAM-barium hexa-aluminate ($0.82\text{BaO}\cdot 6\text{Al}_2\text{O}_3$) exhibits improved color stability and maintenance but has an undesirable color point. New mixtures or blends of blue VUV phosphors have also been disclosed with improved maintenance characteristics such as $(\text{La}_{1-x-y-z}\text{Tm}_x\text{Li}_y\text{AE}_z)\text{PO}_4$ mixed with BAM, Eu^{2+} -activated barium magnesium lanthanum aluminate, Eu^{2+} -activated alkaline earth chloroapatite, or Eu^{2+} -activated calcium chloroborate phosphors, U.S. Patent No. 6,187,225; and BAM or SCAP

(Ba,Sr,Ca)₅(PO₄)₃Cl:Eu mixed with a wide number of UV-C light em
U.S. Patent Publication No. 2001/0033133 A1.

Although many of these phosphors or phosphor complexes exhibit improvements in
5 color and intensity stability, none have yet proven to be viable alternatives. Thus, there
is still a need for improved blue-emitting VUV-excited phosphors. In particular, the
following properties would be desirable: a deeper blue color, improved color stability
during panel manufacture, improved lifetime during panel operation, and a high relative
percent maintenance of the I/y ratio after accelerated thermal, humidity, Xe plasma, and
10 high intensity VUV photon flux testing.

Summary of the Invention

It has been discovered that an europium-activated, calcium-substituted barium hexa-
aluminate (CBAL) phosphor can be used in VUV-excited devices as an acceptable
15 blue-emitting phosphor without suffering the degradation exhibited by BAM
phosphors. CBAL phosphors have been previously described as a conventional
fluorescent phosphor in U.S. Patent No. 4,827,187, for use with mercury vapor
discharges, but have not heretofore been described for use in VUV-excited devices.
Preferably, the CBAL phosphor has a composition represented by the formula Ba_{1.29-x-}
20 _yCa_xEu_yAl₁₂O_{19.29}, wherein 0 < x < 0.25 and 0.01 < y < 0.20.

Under VUV excitation, CBAL phosphors exhibit a deeper blue emission peak than
BAM phosphors, but with only 80 – 85% the initial intensity of a commercially
available BAM phosphor. However, upon exposure to elevated temperature and
25 humidity conditions, CBAL phosphors exhibit very nearly zero green shift in the color
point and very little loss of intensity. Furthermore, upon exposure to a high intensity
VUV photon flux used as an accelerated aging test, the CBAL phosphor exhibits less
than ½ the intensity degradation found in a commercial BAM phosphor and very nearly
no color shift. CBAL phosphors may be also coated with an aluminum oxyhydroxide
30 coating resulting in additional improvements to its maintenance when exposed to the
high intensity VUV photon flux. These coated phosphors will be hereinafter referred to

by the acronym cCBAL. The CBAL phosphors may also be used in c
other blue-emitting phosphors. In particular, CBAL and cCBAL ph
blended with a BAM phosphor, a BAM phosphor having an aluminum oxyhydroxide
coating (cBAM), or thulium- and lithium-activated gadolinium lanthanum phosphate
5 (LaPOT), (Gd,La)PO₄:Tm,Li, a near-UV-, blue-, and IR- emitting phosphor which is
described in U.S. Patent Nos. 6,187,225, 5,989,454, and 6,419,852.

Brief Description of the Drawing

The Figure is a cross-sectional illustration of a VUV-excited device.

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Detailed Description of the Invention

For a better understanding of the present invention, together with other and further
objects, advantages and capabilities thereof, reference is made to the following
disclosure and appended claims taken in conjunction with the above-described drawing.

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The Figure illustrates a type of VUV-excited device which is generally referred to as a
dielectric barrier discharge lamp. The flat rectangular-shaped device is shown in cross
section. The discharge vessel 10 is constructed of a transparent material such as glass
and comprises a front plate 3 and a back plate 2 which are joined by frame 5 at the
20 periphery of the plates. The discharge vessel 10 encloses discharge chamber 15 which
contains a rare gas, typically xenon, or mixture of rare gases, and is used to generate a
discharge which emits vacuum ultraviolet (VUV) radiation. The back plate 2 has
multiple strip electrodes 6 which may serve as anodes and cathodes during operation.
At least some of the electrodes 6' are covered with a dielectric barrier layer 7. The
25 inner surface of the top plate 3 and back plate 2 are coated with a phosphor layer 11 for
converting at least some of the VUV radiation into visible light. Further examples of
dielectric barrier discharge lamps are described in U.S. Patent Nos. 6,566,810,
6,246,171 and 6,469,435. Examples of plasma display panels are described in U.S.
Patent Nos. 6,713,959 and 6,726,519.

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Laboratory tests have been designed to simulate actual PDP panel m
use, including a thermal humidity test and an accelerated aging test. 1
and after the thermal humidity and accelerated aging tests were obtained by measuring
emission spectra using a Perkin-Elmer LS-50B spectrometer and quantifying them
5 relative to the emission spectrum of a standard BAM phosphor reference. The peak
wavelengths at maximum intensity were derived from the spectra and the y coordinate
color values were calculated from the spectral data using well-known and accepted
equations based on X, Y, Z – tristimulus curves. The excitation source is a
commercially available xenon excimer lamp (XeCM-L from Resonance, Ltd., Barrie,
10 Ontario, Canada) used to illuminate powder plaques while excluding air from the VUV
beam path. The phosphor can also be mixed into a paste, coated onto alumina chips or
“slides” and dried, and measured in this fashion.

The thermal humidity test involves exposing the phosphor samples to a warm, water-
15 saturated air flow at 425 °C for 2 hours. The accelerated aging test involves exposure
to a high intensity Xe plasma and VUV photon flux. The accelerated aging test is
performed in a high-power, rare-gas discharge chamber. The chamber consists of a 100
cm loop of 5 cm I.D. PyrexTM tubing that has approximately 5 millitorr of flowing Xe
after it is initially evacuated to a 10^{-6} torr vacuum. An inductively coupled discharge is
20 obtained by applying approximately 280 watts of input power at 450 kHz from an RF
power supply. It is estimated that there is approximately 90 milliwatts/cm² of 147 nm
VUV radiation at the sample surface. No significant excimer emission is generated
under these conditions. After a selected amount of exposure time, the phosphor
samples were measured for brightness as described above. Limited results for PDP
25 panels indicate that such accelerated tests do indeed simulate actual PDP panel
manufacturing and usage conditions. The results of these tests may also be used to
predict phosphor performance in other types of VUV-excited devices such as dielectric
barrier discharge lamps.

30 Examples

CBAL phosphors can be made by thoroughly blending aluminum hydroxide carbonate, calcium carbonate, europium oxide, and barium fluoride and then firing the resulting mixture in alumina or alumina-based trays for between 2 and 4 hours at 1400°C to 1600°C in a reducing furnace under a nitrogen-hydrogen atmosphere (ranging from 5% hydrogen to 75% hydrogen with the remainder being nitrogen gas). The fired cakes are then washed in de-ionized water and wet sieved through a 378 mesh screen or alternatively lightly milled before wet sieving. The material is then dried and dry screened through a 60 mesh sieve to break up any possible agglomerates. Three non-limiting examples of CBAL formulations are listed below. Formulation #1 was used to prepare the samples for accelerated testing. Formulation variations can be used to prepare similar phosphors with similar properties.

CBAL Formulation #1

15	Reagent	molar ratio	wt. Ratio (adjusted by assay)
	Al(OH) ₃	11.0000	6.9076
	CaCO ₃	0.1700	0.1366
	BaF ₂	0.1000	0.1407
	Eu ₂ O ₃	0.0400	0.1153
20	BaCO ₃	0.8325	1.3251

CBAL Formulation #2

	Reagent	molar ratio	wt. Ratio (adjusted by assay)
	Al(OH) ₃	11.0000	3.3458
25	CaCO ₃	0.1500	0.0602
	BaF ₂	0.1000	0.0704
	Eu ₂ O ₃	0.0400	0.0576
	BaCO ₃	0.8525	0.6785

CBAL Formulation #3

	Reagent	molar ratio	wt. Ratio (adjusted by ass:
	Al(OH) ₃	11.0000	3.443
	CaCO ₃	0.1000	0.040
5	H ₃ BO ₃	0.20 wt%	0.009
	Eu ₂ O ₃	0.0400	0.056
	BaCO ₃	1.003	0.794

The procedure for applying an aluminum oxyhydroxide coating in order to form the
 10 cCBAL and cBAM phosphors involves suspending the powders in a fluidized bed
 reactor in which vaporized trimethylaluminum (TMA) and water vapor are reacted at
 about 430°C to form an aluminum oxyhydroxide coating. A nitrogen gas stream is
 introduced into the base of the reactor through a metal frit distributor plate in order to
 fluidize the bed of phosphor particles. The reactor is then heated to about 430°C by an
 15 external furnace. Vaporized TMA from a heated TMA bubbler (34°C) and water vapor
 from a heated water bubbler (70°C) are entrained in separate nitrogen gas streams. The
 TMA/nitrogen stream is combined with the nitrogen fluidizing gas and passed into the
 reactor through the distributor plate. After saturating the phosphor particles with TMA
 vapor for about one minute, the water vapor/nitrogen stream is introduced into the
 20 reactor through a central distributor. The central distributor is preferably a perforated
 hollow shaft which has been inserted into the reactor through the top and may be part of
 a vibrating mixer used to keep the particles fluidized. The TMA and water react to
 form an aluminum oxyhydroxide coating on the phosphor particles. The thickness of
 the coating on the individual particles may be adjusted by manipulating the time spent
 25 in the reactor, the concentrations of the reactants in the gas streams, and the flow rates
 of the reactant gas streams.

Blends of CBAL-BAM and cCBAL-BAM phosphors were prepared by adding amounts
 of the two components to a clean glass container and then thoroughly mixing them by a
 30 roll-blending technique. Such mixtures can easily be modified to give the desired
 properties by adjusting the weight ratios of the two components.

Blends of CBAL - LaPOT and cCBAL - LaPOT were prepared by quantities of the two components to glass containers along with a small amount of media and de-ionized water and thoroughly mixing the material by roll-blending for 20
5 minutes. The media were removed and the samples were dried before testing. As stated before, such mixtures can easily be modified to give the desired properties by adjusting the weight ratios of the two components. Preferably, the ratios of the CBAL:LaPOT components will range from 2:1 to 20:1 by weight.

10 Test Results

Samples of CBAL, cCBAL, cBAM, CBAL-BAM mixtures, CBAL-cBAM mixtures, CBAL-LaPOT mixtures, and cCBAL-LaPOT mixtures were measured along with a sample of commercially available BAM phosphor (used as the control) for initial
15 intensity relative to a standard. The VUV emission spectra were collected using the Perkin-Elmer LS-50B spectrometer previously described. The samples were then degraded through the thermal-humidity treatment previously described and the VUV intensities were re-measured. All samples were degraded under experimentally equivalent conditions. The same samples were further degraded through exposure to a
20 high intensity Xe plasma and VUV photon flux using the apparatus previously described and their VUV intensities re-measured.

Table 1 provides the results of the powder plaque optical emission measurements for the initial and degraded VUV-excited phosphors. The term "TH" refers to samples
25 degraded by exposure to elevated temperature and humidity. The term "THX" denotes samples which have been further degraded after the TH testing by exposure to the high intensity Xe plasma and VUV photon flux. Intensity is measured relative to a standard BAM phosphor. The blend ratios in parentheses are given in terms of phosphor weight.

Table 1

Powder Plaque Data							
	BAM control	CBAL	cBAM	CBAL - BAM (1:1)	CBAL - cBAM (1:1)	CBAL - LaPOT (5:1)	CBAL - LaPOT (11:1)
Intensity (initial)	96%	80%	82%	87%	81%	75%	77%
Peak λ (initial)	447 nm	440 nm	448 nm	444 nm	444 nm	440 nm	440 nm
y value (initial)	0.0466	0.0552	0.0476	0.0505	0.0508	0.0588	0.0582
Intensity (TH)	88%	76%	79%	81%	76%	72%	74%
Peak λ (TH)	458 nm	440 nm	456 nm	449 nm	448 nm	440 nm	440 nm
(TH) y value	0.0852	0.0564	0.0806	0.0719	0.0701	0.0581	0.0575
%(I/y) (TH)	50%	93%	57%	65%	68%	96%	98%
Intensity (THX)	52%	48%	57%	49%	49%	46%	48%
Peak λ (THX)	456 nm	440 nm	455 nm	447 nm	448 nm	440 nm	440 nm
y value (THX)	0.0931	0.0632	0.0912	0.0759	0.0785	0.0675	0.0668
%(I/y) (THX)	27%	53%	36%	37%	40%	54%	55%

- 5 Although the BAM control sample exhibits the greatest initial intensity, it also exhibits the worst degradation as measured by the %(I/y) ratio. The I/y ratio after thermal-humidity testing is only 50% of the initial I/y ratio for the BAM control and 27% of the initial I/y ratio after thermal-humidity and high intensity Xe plasma – VUV photon flux testing. Its final intensity (THX) is at most 6% higher than the least intense sample while initially the BAM control was as much as 16% higher than the least intense sample.
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All of the experimental samples exhibit significantly better maintenance than does the BAM control. In particular, the CBAL and CBAL-LaPOT mixtures exhibit superior maintenance of the I/y ratio after degradation testing. The TH samples are more than 80% better than BAM, maintaining at least 93% of the initial I/y ratio after thermal humidity testing (vs. 50% for the control) and the THX samples are nearly 100% better than BAM, maintaining at least 53% of the initial I/y ratio after thermal-humidity and high intensity Xe plasma – VUV photon flux testing (vs. 27% for the control). In addition, all CBAL-containing samples have a bluer peak wavelength both before and after TH and THX treatments compared to the BAM control. The CBAL-BAM and CBAL-cBAM mixtures show improved degradation maintenance over BAM and cBAM alone, respectively.

Table 2 provides the results of powder plaque and paste slide optical emission results from initial and degraded VUV-excited phosphors. As in Table 1, intensity is measured relative to a standard BAM phosphor and the blend ratios in parentheses are given in terms of phosphor weight. The term "X" denotes samples which have been degraded only by exposure to the high intensity Xe plasma and VUV photon flux. In an effort to obtain data which more closely approximated PDP panel manufacturing, paste slide data was obtained by mixing the phosphor samples with a paste designed for PDP panels, e.g., the paste described in U.S. Patent No. 6,660,184.

Table 2

	Powder Plaque Data			Paste Slide Data				
	BAM (control)	CBAL	cCBAL	BAM (control)	CBAL	cCBAL	CBAL- LaPOT (9:1)	cCBAL- LaPOT (9:1)
Intensity (initial)	96%	76%	68%	104%	84%	79%	84%	77%
Peak λ (initial)	446 nm	439 nm	439 nm	446 nm	439 nm	439 nm	439 nm	439 nm
Initial y value	0.0465	0.0568	0.0553	0.0466	0.0518	0.0517	0.0518	0.0523
Intensity (.H)	87%	74%	69%	96%	82%	79%	79%	77%
Peak λ (TH)	456 nm	439 nm	439 nm	456 nm	439 nm	439 nm	439 nm	439 nm
(TH) y value	0.0803	0.0571	0.0566	0.0771	0.0527	0.0542	0.0535	0.0546
%(I/y) (TH)	52%	96%	98%	56%	96%	95%	91%	96%
Intensity (X)	57%	42%	49%	76%	61%	66%	67%	69%
Peak λ (X)	446 nm	439 nm	439 nm	446 nm	439 nm	439 nm	439 nm	439 nm
(X) y value	0.0527	0.0625	0.0608	0.0504	0.0565	0.0563	0.0573	0.0568
%(I/y) (X)	53%	50%	65%	68%	66%	76%	72%	82%
Intensity (THX)	52%	47%	49%	64%	60%	65%	63%	63%
Peak λ (THX)	454 nm	439 nm	439 nm	454 nm	439 nm	439 nm	439 nm	439 nm
(THX) y value	0.0901	0.0642	0.0633	0.0905	0.0596	0.0602	0.0602	0.0606
%(I/y) (THX)	28%	54%	63%	32%	62%	70%	65%	70%

5 The degradation results from powder and paste preparations of the same samples are basically equivalent. Although the paste brightness results tend to be higher than the powder brightness values, they are relatively the same. The peak wavelength at

maximum intensity does not change for either the CBAL or cCBAL. The BAM control sample shows a large shift in color after the thermal humidity test. The initial brightness for the BAM control is much higher than the initial brightness of the CBAL, cCBAL, CBAL-LaPOT, and cCBAL-LaPOT samples, while after exposure to the thermal humidity test and the high intensity Xe plasma and VUV photon flux, all samples have comparable brightness. The maintenance of in terms of $\% (I/y)$ for the CBAL sample after (THX) thermal humidity and Xe plasma testing is vastly superior to that of the BAM control (54% vs. 28% and 62% vs 32%, respectively) and the maintenance of the aluminum oxyhydroxide-coated CBAL (cCBAL) is further superior to that of uncoated CBAL. The cCBAL material also exhibits significantly improved maintenance after high intensity Xe plasma and VUV photon flux exposure without any thermal humidity tests being involved. The CBAL-LaPOT and cCBAL-LaPOT blends behave similarly to the CBAL and cCBAL components, but show higher maintenance values.

While there has been shown and described what are at the present considered the preferred embodiments of the invention, it will be obvious to those skilled in the art that various changes and modifications may be made therein without departing from the scope of the invention as defined by the appended claims.